

IEEE Waveform Generation Measurement and Analysis Technical Committee (TC10)
Meeting Agenda
21 June 2021 / 11:00 AM – 2:00 PM (EDT)

1. Call to Order
2. Introductions and Roll Call
3. Roberts Rules of Order Overview
4. Approval of the Agenda
5. TC10 Policies and Procedures (P&P) Review
 - a. Standards Committee P&P
 - b. Common Individual based WG P&P
6. IEEE SA eTools
 - a. Listserv – email reflector
 - i. IM-WMA-TC10@LISTSERV.IEEE.ORG
 - ii. IM-WMA-TC10-OFFICERS@LISTSERV.IEEE.ORG
 - b. WebEx – for virtual mtgs
 - c. myProject - <https://development.standards.ieee.org/myproject-web/public/view.html#landing>
 - d. iMeet Central – document repository <https://ieee-sa.imeetcentral.com/login>
 - e. WordPress – TC10 website <https://sagroups.ieee.org/im-wma-tc10/>
 - i. IEEE IMS website <http://tc10.ieee-ims.org/tc10-home>
7. Working Groups Updates
 - a. Revision of IEE Std 181, IEEE Standard for Transitions, Pulses, and Related Waveforms
 - i. Lead: Nick Paulter
 - ii. PAR: <https://development.standards.ieee.org/myproject-web/app#viewpar/12338/8862>
 - b. Revision of IEEE Std 1241, IEEE Standard for Terminology and Test Methods for Analog-to-Digital Converters
 - i. Lead: Nick Paulter (acting)
 - ii. PAR: <https://development.standards.ieee.org/myproject-web/app#viewpar/5745/5745>
 - c. Revision of IEEE Std 1658, IEEE Standard for Terminology and Test Methods of Digital-to-Analog Converter Devices
 - i. Lead: Luca DeVito
 - ii. PAR: <https://development.standards.ieee.org/myproject-web/app#viewpar/6538/6538>
 - d. Revision of IEEE Std 1696, IEEE Standard for Terminology and Test Methods for Circuit Probes
 - i. Lead: John Jendzurski
 - ii. PAR: <https://development.standards.ieee.org/myproject-web/app#viewpar/12343/8867>

8. Future Meetings
 - a. Frequency
 - b. Duration
 - c. Content
 - i. General Information
 - ii. Working Groups/Subcommittee Updates
 - iii. Related activities in other Standards Development Organizations

9. Adjourn